

MOSFETs Silicon N-Channel MOS (DTMOSVI)

# TK200E65Z5

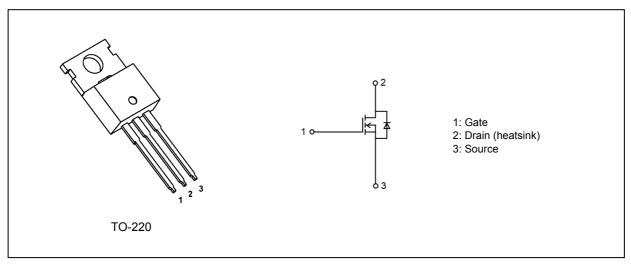
### 1. Applications

• Switching Voltage Regulators

#### 2. Features

- (1) Fast reverse recovery time:  $t_{rr} = 95$  ns (typ.)
- (2) Low drain-source on-resistance:  $R_{DS(ON)} = 0.154 \Omega$  (typ.)
- (3) High-speed switching properties with lower capacitance.
- (4) Enhancement mode:  $V_{th} = 3.5 \text{ to } 4.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 0.61 \text{ mA)}$

## 3. Packaging and Internal Circuit





# 4. Absolute Maximum Ratings (Note) (Ta = 25 °C unless otherwise specified)

Characteristics	Symbol	Rating	Unit	
Drain-source voltage		V <sub>DSS</sub>	650	V
Gate-source voltage	,	V <sub>GSS</sub>	±30	
Drain current (DC)	(Note 1)	I <sub>D</sub>	15	Α
Drain current (pulsed)	(Note 1)	I <sub>DP</sub>	60	
Power dissipation (T <sub>c</sub> = 25	5 °C)	$P_{D}$	130	W
Single-pulse avalanche energy	(Note 2)	E <sub>AS</sub>	204	mJ
Single-pulse avalanche current	,	I <sub>AS</sub>	3	Α
Reverse drain current (DC)	(Note 1)	I <sub>DR</sub>	15	
Reverse drain current (pulsed)	(Note 1)	I <sub>DRP</sub>	60	
Channel temperature	,	T <sub>ch</sub>	150	ů
Storage temperature		T <sub>stg</sub>	-55 to 150	
Mounting torque	· · · · · ·	TOR	0.6	N · m

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### 5. Thermal Characteristics

Characteristics	Symbol	Max	Unit
Channel-to-case thermal resistance	R <sub>th(ch-c)</sub>	0.961	°C/W
Channel-to-ambient thermal resistance	R <sub>th(ch-a)</sub>	83.3	

Note 1: Ensure that the channel temperature does not exceed 150 °C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25 °C (initial), L = 40.2 mH,  $I_{AS}$  = 3 A

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

#### 6. Electrical Characteristics

### 6.1. Static Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±1	μΑ
Drain cut-off current	I <sub>DSS</sub>	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	_	_	100	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	650	_	_	V
Gate threshold voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.61 mA	3.5	_	4.5	
Drain-source on-resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.5 A	_	0.154	0.200	Ω



# 6.2. Dynamic Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 300 V, V <sub>GS</sub> = 0 V, f = 100	_	1400	_	pF
Reverse transfer capacitance	C <sub>rss</sub>	kHz	_	1.2	_	
Output capacitance	C <sub>oss</sub>		_	38	_	
Effective output capacitance (Note (energy related)	3) C <sub>o(er)</sub>	V <sub>DS</sub> = 0 to 400 V, V <sub>GS</sub> = 0 V	_	58	_	
Effective output capacitance (Note (time related)	4) C <sub>o(tr)</sub>	V <sub>DS</sub> = 0 to 400 V, V <sub>GS</sub> = 0 V	_	375	_	
Gate resistance	r <sub>g</sub>	V <sub>DS</sub> = OPEN , f = 1 MHz	_	2.8	_	Ω
Switching time (rise time)	t <sub>r</sub>	See Fig. 6.2.1	_	18	_	ns
Switching time (turn-on time)	t <sub>on</sub>		_	40	_	
Switching time (fall time)	t <sub>f</sub>		_	4.4	_	
Switching time (turn-off time)	t <sub>off</sub>		_	60	_	
MOSFET dv/dt ruggedness	dv/dt	$V_{DS} \le V_{DSS}, I_D \le 7.5 A$	90	_	_	V/ns

Note 3:  $C_{O(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 V to 400 V. Note 4:  $C_{O(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 V to 400 V.

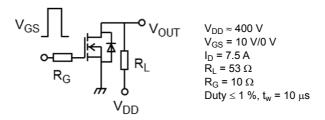


Fig. 6.2.1 Switching Time Test Circuit



# 6.3. Gate Charge Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$	_	26		nC
Gate-source charge 1	Q <sub>gs1</sub>			8.8		
Gate-drain charge	Q <sub>gd</sub>		_	8.8	_	

# 6.4. Source-Drain Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage		$V_{DSF}$	I <sub>DR</sub> = 15 A, V <sub>GS</sub> = 0 V	_	_	-1.7	٧
Reverse recovery time	(Note 5)	t <sub>rr</sub>	V <sub>DD</sub> = 400 V,	_	95	152	ns
Reverse recovery charge		Q <sub>rr</sub>	I <sub>DR</sub> = 7.5 A, V <sub>GS</sub> = 0 V -dI <sub>DR</sub> /dt = 100 A/μs	_	0.4	_	μС
Peak reverse recovery current		I <sub>rr</sub>	αι <sub>DR</sub> /αι	_	8.4	_	А
Diode dv/dt ruggedness		dv/dt	$V_{DD} \le 400 \text{ V}, I_{DR} \le 7.5 \text{ A}, V_{GS} = 0 \text{ V}$	70	_	_	V/ns

Note 5: Defined by design.

## 7. Marking

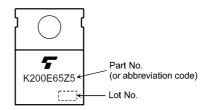


Fig. 7.1 Marking



#### 8. Characteristics Curves (Note)

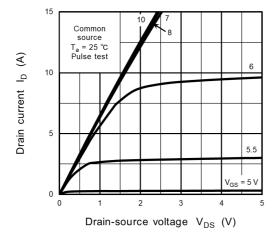


Fig. 8.1 I<sub>D</sub> - V<sub>DS</sub>

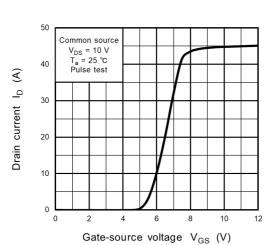


Fig. 8.3 ID - VGS

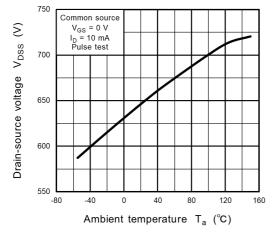


Fig. 8.5 V<sub>DSS</sub> - T<sub>a</sub>

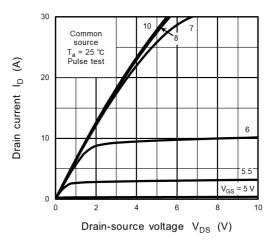


Fig. 8.2 I<sub>D</sub> - V<sub>DS</sub>

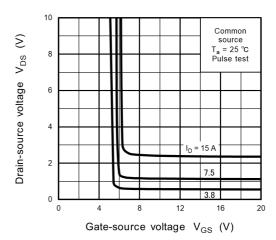


Fig. 8.4 V<sub>DS</sub> - V<sub>GS</sub>

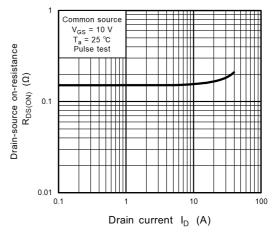


Fig. 8.6 R<sub>DS(ON)</sub> - I<sub>D</sub>



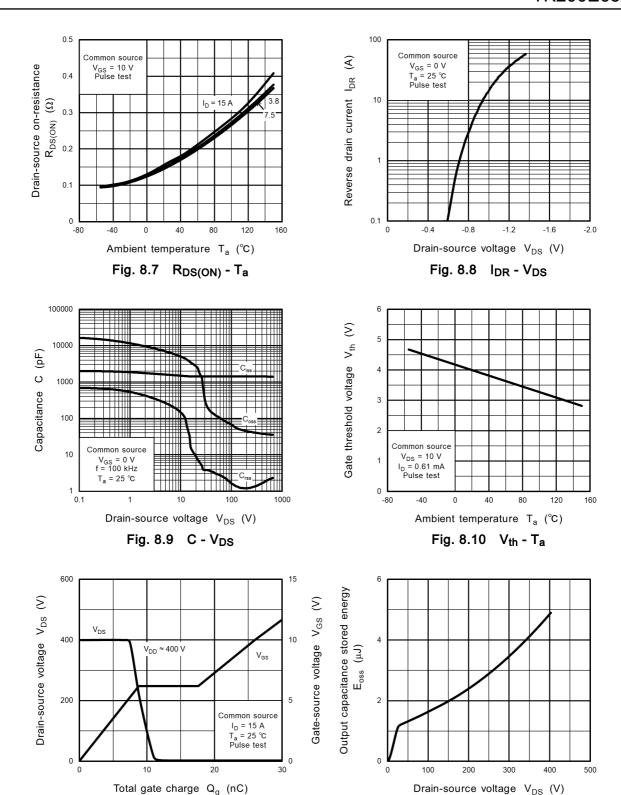


Fig. 8.11 Dynamic Input/Output Characteristics

Fig. 8.12 Eoss - V<sub>DS</sub>



250

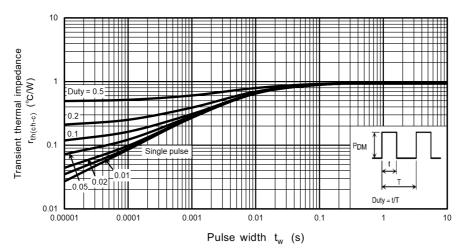


Fig. 8.13 r<sub>th</sub> - t<sub>w</sub> (Guaranteed Maximum)

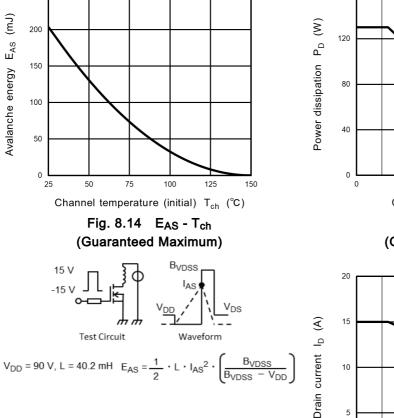


Fig. 8.16 Test Circuit/Waveform

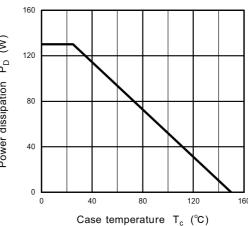


Fig. 8.15 P<sub>D</sub> - T<sub>c</sub> (Guaranteed Maximum)

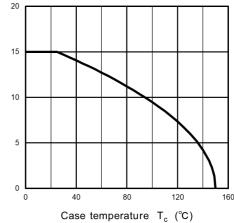


Fig. 8.17 I<sub>D</sub> - T<sub>c</sub> (Guaranteed Maximum)



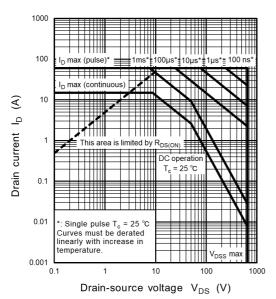


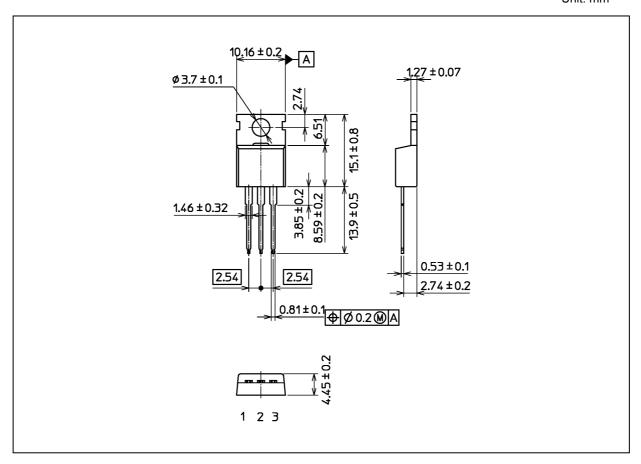
Fig. 8.18 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



# **Package Dimensions**

Unit: mm



Weight: 1.93 g (typ.)

	Package Name(s)
TOSHIBA: 2-10X1A	
Nickname: TO-220	



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